A tool for pattern information extraction and defect quantification from crystal structures

Erhan Okuyan a,*, Erkan Okuyan b

a TAI Inc., Ankara, Turkey
b Computer Engineering Department, Bilkent University, Ankara, Turkey

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ABSTRACT

In this paper, we present a revised version of BilKristal 2.0 tool. We added defect quantification functionality to assess crystalline defects. We improved visualization capabilities by adding transparency support and runtime visibility sorting. Discovered bugs are fixed and small performance optimizations are made.

New version program summary

Program title: BilKristal 3.0
Catalogue identifier: ADYU_v3_0
Program summary URL: http://cpc.cs.qub.ac.uk/summaries/ADYU_v3_0.html
Program obtainable from: CPC Program Library, Queen’s University, Belfast, N. Ireland
No. of lines in distributed program, including test data, etc.: 1868923
No. of bytes in distributed program, including test data, etc.: 8854507
Distribution format: tar.gz
Computer: Personal Computers with Windows operating system.
Operating system: Windows XP or higher.
RAM: 20–60 Megabytes.
Classification: 8.
Catalogue identifier of previous version: ADYU_v2_0
External routines: Microsoft .NET Framework 2.0. For the visualization tool, graphics card driver should also support OpenGL.

Nature of problem:
Determining the crystal structure parameters of a material is a very important issue in crystallography. Knowing the crystal structure parameters helps the understanding of the physical behavior of material. For complex structures, particularly for materials which also contain local symmetry as well as global symmetry, obtaining crystal parameters can be very hard.

Solution method:
The tool extracts crystal parameters such as primitive vectors, basis vectors and identifies the space group from atomic coordinates of crystal structures.

Reasons for new version:
Additional features, Compatibility issues with newer development environments, Performance optimizations, Minor bug corrections.

Summary of revisions:

- Defect quantification capability is added. The tool can process the imperfect crystal structures, finds and quantifies the crystalline defects. The tool is capable of finding positional defects, vacancy defects, substitutional impurities and interstitial impurities. The algorithms presented in [3] are used for defect quantification implementation.

* Corresponding author. Tel.: +90 5366720664.
E-mail addresses: okuyan@cs.bilkent.edu.tr (E. Okuyan), eokuyan@cs.bilkent.edu.tr (E. Okuyan).

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• Transparency support is added to the visualization tool. Users are now allowed to set the transparency of each atom type individually.
• Runtime visibility sorting functionality is added to facilitate correct transparency computations.
• Visual Studio 2012 support is added. Visual Studio 2012 specific project files are created and the project is tested with this development environment.
• In visualization tool, an unused log file was created. This issue is corrected.
• In visualization tool, some OpenGL calls which are executed at every draw are changed to be executed only when they are needed, improving the visualization performance.

Restrictions:
Assumptions are explained in [1,2]. However, none of them can be considered as a restriction onto the complexity of the problem.

Running time:
The tool was able to process input files with more than a million atoms in less than 20 s on a PC with an Athlon quad-core CPU at 3.2 GHz using the default parameter values.

References:
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